MT3245

N-Channel Power MOSFET 45V, 120A, $3m\Omega$

Features

- $R_{DS(on)} = 3m\Omega (Typ.)@V_{GS} = 10V, I_D = 80A$
- $Q_{g(tot)} = 345nC (Typ.)@V_{GS} = 10V$
- · Low Miller Charge
- Low Q_{RR} Body Diode
- · UIS Capability (Single Pulse and Repetitive Pulse)
- · Rohs Comliant

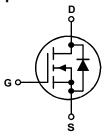
Applications

- · Automotive Engine Control
- · Powertrain Management
- · Motors, Solenoids
- · Electronic Steering
- · Integrated Starter/ Alternator
- · Distributed Power Architectures and VRMs
- Primary Switch for 12V Systems

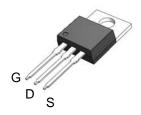


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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



TO-220FB-3L

Absolute Maximum Ratings(T_A = 25^oC unless otherwise noted)

Symbol		Parameter	Ratings	Units
V _{DSS}	Drain to Source Voltag	е	45	V
V _{GSS}	Gate to Source Voltage	Э	±20	V
I _D	Drain Current	- Continuous (T _C = 25°C, Silicon Limited) - Continuous (T _C = 100°C, Silicon Limited) - Continuous (T _C = 25°C, Package Limited)	120* 90* 35	A
I _{DM}	Drain Current	- Pulsed (Note 1)	400	Α
E _{AS}	Single Pulsed Avalance	he Energy (Note 2)	1232	mJ
D	Davis Diaglastics	(T _C = 25°C)	206	W
P_{D}	Power Dissipation	- Derate above 25°C	2.04	W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +175	°C
TL	·	um Lead Temperature for Soldering Purpose, om Case for 5 Seconds		°C

*Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 100A.

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.79	°C/W
$R_{\theta CS}$	Thermal Resistance, Case to Sink (Typ.)	0.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	69.5	°C/W

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Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT3245	MT3245	TO-220	N/A	N/A	50units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Conditions		Min	Тур	Max	Units
Off Charac	teristics	!			ļ	I	
BV _{DSS}	Drain to Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu$					V
		V _{DS} = 32V				1	μА
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0V	T _C = 150°C			250	μА
I _{GSS}	Gate to Body Leakage Current	V _{GS} = ±20V	•			±100	nA
On Charac	teristics			•			
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	ı	1		3	V
		V _{GS} = 4.5V, I _D = 80A				6	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 80A			3	4	$m\Omega$
		V _{GS} = 10V, I _D = 80A, T _C = 175°C	V _{GS} = 10V, I _D = 80A,			7	. 11152
Dynamic C	haracteristics						
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz			15500	20110	pF
C _{oss}	Output Capacitance				1740	2050	pF
C _{rss}	Reverse Transfer Capacitance				1500	2000	pF
R _G	Gate Resistance	V _{GS} = 0.5V, f = 1MHz			1.1		Ω
Q _{g(tot)}	Total Gate Charge at 10V	V _{GS} = 0V to 10V			345	450	nC
Q _{g(2)}	Threshold Gate Charge	V _{GS} = 0V to 2V	V _{DD} = 20V		32.5		nC
Q _{gs}	Gate to Source Gate Charge		I _D = 80A		49		nC
Q _{gs2}	Gate Charge Threshold to Plateau	I _g = 1.0mA			16.5		nC
Q _{gd}	Gate to Drain "Miller" Charge				74		nC
Switching	Characteristics (V _{GS} = 10V)			•		•	•
t _{ON}	Turn-On Time				175	360	ns
t _{d(on)}	Turn-On Delay Time	00)// 000			43	95	ns
t _r	Rise Time	$V_{DD} = 20V, I_{D} = 80A$ $V_{GS} = 10V, R_{GEN} = 7\Omega$			130	275	ns
t _{d(off)}	Turn-Off Delay Time	GS - , GEN			435	875	ns
t _f	Fall Time				290	590	ns
t _{OFF}	Turn-Off Time				730	1470	ns
Drain-Sour	rce Diode Characteristics and Maximu	ım Ratings		1	1	1	1
.,	Source to Drain Diade Valters	I _{SD} = 80A				1.25	V
V_{SD}	Source to Drain Diode Voltage	I _{SD} = 40A				1.0	V
t _{rr}	Reverse Recovery Time	I _{SD} = 75A, dI _{SD} /dt = 100A/μs			59		ns
Q _{RR}	Reverse Recovery Charge	I _{SD} = 75A, dI _{SD} /dt = 100A/μs			77		nC

NOTES

^{1:} Pulse width limited by maximum junction temperature.

^{2:} Starting T $_{J}$ = 25°C, L = 1mH, I $_{AS}$ = 58A, V $_{DD}$ = 36V, V $_{GS}$ = 10V.

Typical Performance Characteristics

Figure 1. On-Region Characteristics

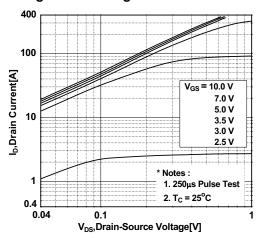


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

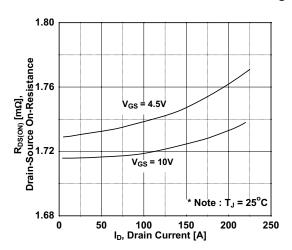


Figure 5. Capacitance Characteristics

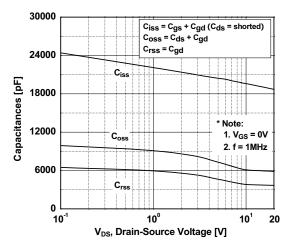


Figure 2. Transfer Characteristics

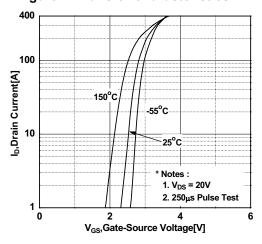


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

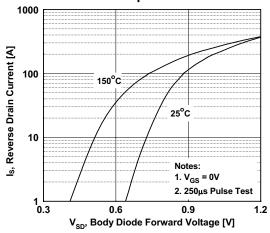
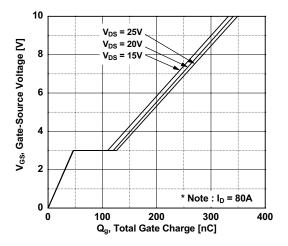


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

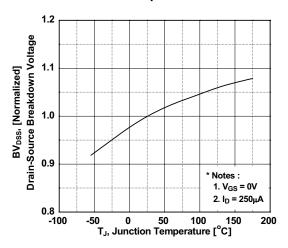


Figure 9. Unclamped Inductive Switching Capability

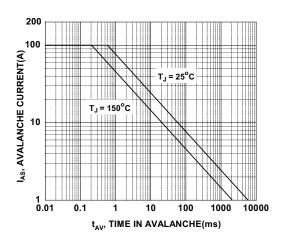


Figure 8. On-Resistance Variation vs. Temperature

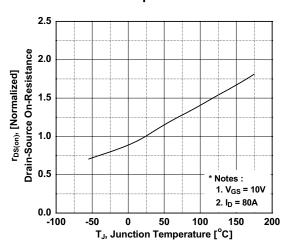


Figure 10. Safe Operating Area

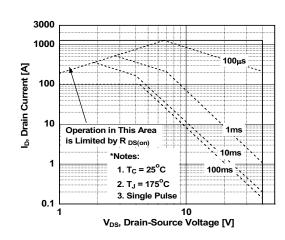
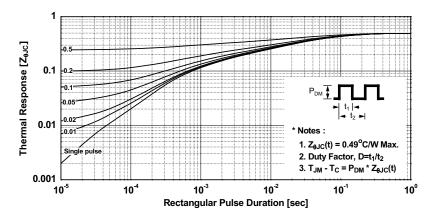
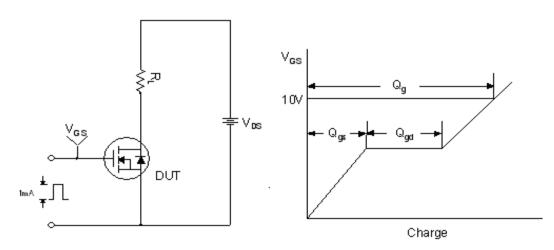


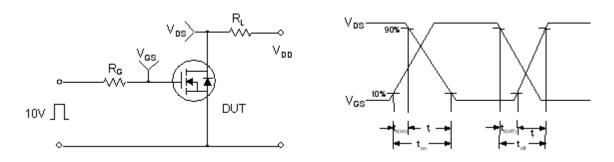
Figure 11. Transient Thermal Response Curve



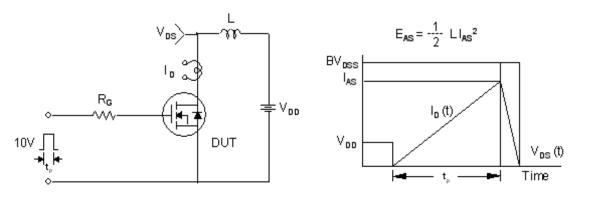
Gate Charge Test Circuit & Waveform



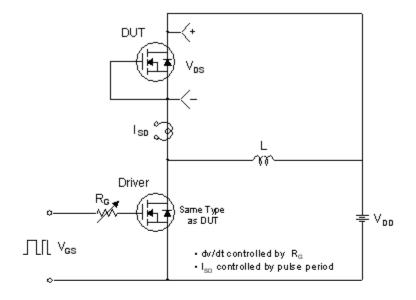
Resistive Switching Test Circuit & Waveforms

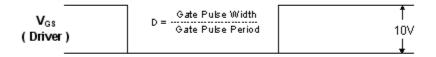


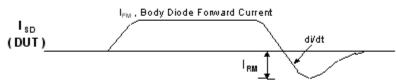
Unclamped Inductive Switching Test Circuit & Waveforms



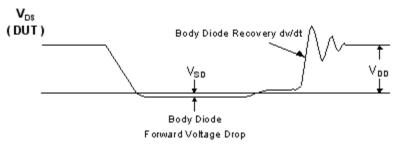
Peak Diode Recovery dv/dt Test Circuit & Waveforms





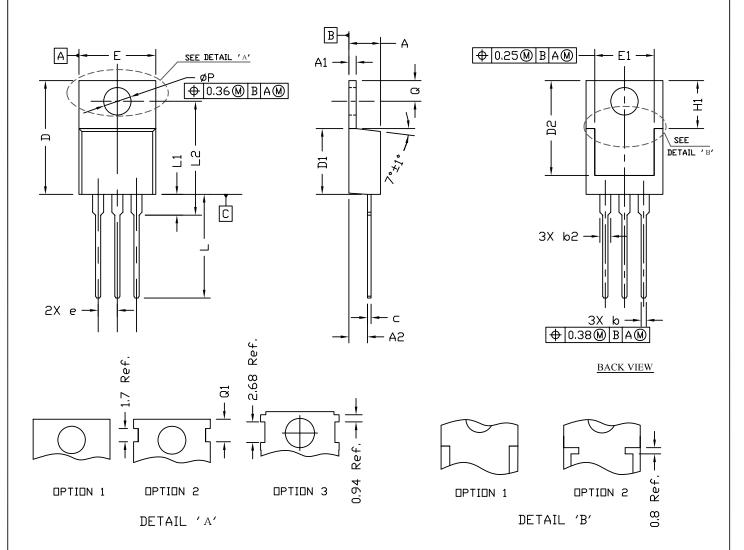


Body Diode Reverse Current

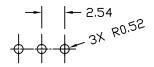


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Version	L

TO220 PACKAGE OUTLINE



RECOMMENDATION OF HOLE PATTERN



UNIT: mm

NOTE

- PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH SHOULD BE LESS THAN 6 MIL.
- 2. TOLERANCE 0.100 MILLIMETERS UNLESS OTHERWISE SPECIFIED.
- 3. CONTROLLING DIMENSION IS MILLIMETER.
- CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
21MBUL2	MIN	NDM	MAX	MIN	NDM	MAX	
Α	4.30	4.45	4.72	0.169	0.175	0.186	
A1	1.15	1.27	1.40	0.045	0.050	0.055	
A2	2.20	2.67	2.90	0.087	0.105	0.114	
b	0.69	0.81	0.95	0.027	0.032	0.037	
b2	1.17	1.37	1.45	0.046	0.050	0.068	
С	0.36	0.38	0.60	0.014	0.015	0.024	
D	14.50	15.44	15.80	0.571	0.608	0.622	
D1	8.59	9.14	9.65	0.338	0.360	0.380	
D2	11.43	11.73	12.48	0.450	0.462	0.491	
е	2.54 BSC			0.100 BSC.			
Е	9.66	10.03	10.54	0.380	0.395	0.415	
E1	6.22			0.245			
H1	6.10	6.30	6.50	0.240	0.248	0.256	
L	12.27	12.82	14.27	0.483	0.505	0.562	
L1	2.47		3.90	0.097		0.154	
L2			16.70			0.657	
Q	2.59	2.74	2.89	0.102	0.108	0.114	
ØΡ	3.50	3.84	3.89	0.138	0.151	0.153	
Q1	2.70		2.90	0.106		0.114	

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